

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/665,565	<b>Applicant(s)/Patent under Reexamination</b> FUKUI, KOTARO
	<b>Examiner</b> Sam Rimell	<b>Art Unit</b> 2164

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner